

Notice of References Cited	Application/Control No. 10/574,312		Applicant(s)/Patent Under Reexamination YAMAWAKI, TOSHIO	
	Examiner ERIC T. OBERLY		Art Unit 2184	Page 1 of 1

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*	B	US-6,618,788 B1	09-2003	Jacobs, Daniel G.	710/315
*	C	US-6,687,072 B2	02-2004	Okuyama et al.	360/55
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	N	JP 1-217767	08-1989	JP	Nakamura et al.	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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